

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/028,383		DEWAN, ROHIT	
Examiner				Art Unit			
Quynh H. Nguyen				2642			

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
379		265.06		379	265.07	266.01	266.02	266.03	309		
INTERNATIONAL CLASSIFICATION											
H	0	4	M	3/00							
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Quynh H. Nguyen 12/5/05 (Assistant Examiner) (Date)				Ahmed F. Matar AHMAD F. MATAR SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2700 (Primary Examiner) (Date) 12/5/05					Total Claims Allowed: 32		
S. C. (Signature) 12/5/05 (Legal Instruments Examiner) (Date)									O.G. Print Claim(s) 1	O.G. Print Fig. 3	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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